FAIRCHILD SEMICONDUCTOR®

December 2007

FDS8672S

N-Channel PowerTrench® SyncFET™

30V, 18A, 4.8mΩ

Features

- Max $r_{DS(on)}$ = 4.8mΩ at V_{GS} = 10V, I_D = 18A
- Max $r_{DS(on)}$ = 7.0mΩ at V_{GS} = 4.5V, I_D = 15A
- Includes SyncFET Schottky body diode
- High performance trench technology for extremely low $r_{DS(on)}$ and fast switching
- High power and current handling capability
- 100% R_g (Gate Resistance) tested
- Termination is Lead-free and RoHS Compliant

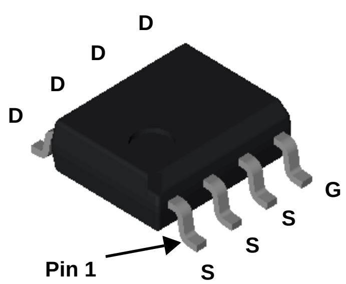
General Description

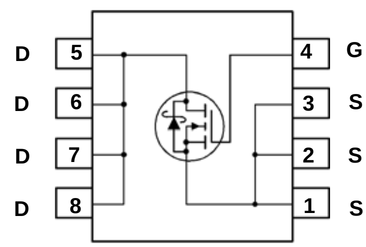
The FDS8672S is designed to replace a single MOSFET and Schottky diode in synchronous DC/DC power supplies. This 30V MOSFET is designed to maximize power conversion efficiency, providing a low $r_{DS(on)}$ and low gate charge. The FDS8672S includes a patented combination of a MOSFET monolithically integrated with a Schottky diode using Fairchild's monolithic SyncFET technology.

Application

- Synchronous Rectifier for DC/DC Converters
- Notebook Vcore low side switch
- Point of load low side switch

SO-8





MOSFET Maximum Ratings T_A = 25°C unless otherwise noted

Symbol	Parameter	Ratings	Units
V_{DS}	Drain to Source Voltage	30	V
V_{GS}	Gate to Source Voltage	±20	V
I_D	Drain Current -Continuous	18	A
	-Pulsed	80	
E_{AS}	Single Pulse Avalanche Energy (Note 3)	216	mJ
P_D	Power Dissipation T_A = 25°C (Note 1a)	2.5	W
	Power Dissipation T_A = 25°C (Note 1b)	1.0	
T_J, T_{STG}	Operating and Storage Junction Temperature Range	-55 to +150	°C

Thermal Characteristics

$R_{\theta JC}$	Thermal Resistance, Junction to Case (Note 1)	25	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient (Note 1a)	50	

Package Marking and Ordering Information

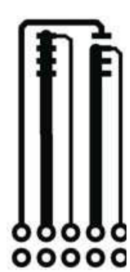
Device Marking	Device	Package	Reel Size	Tape Width	Quantity
FDS8672S	FDS8672S	SO8	13''	12mm	2500 units

Electrical Characteristics T_J = 25°C unless otherwise noted

Symbol	Parameter	Test Conditions	Min	Typ	Max	Units
Off Characteristics						
BV_{DSS}	Drain to Source Breakdown Voltage	I_D = 1mA, V_{GS} = 0V	30			V
$\frac{\Delta BV_{DSS}}{\Delta T_J}$	Breakdown Voltage Temperature Coefficient	I_D = 10mA, referenced to 25°C		33		mV/°C
I_{DSS}	Zero Gate Voltage Drain Current	V_{DS} = 24V, V_{GS} = 0V			500	µA
I_{GSS}	Gate to Source Leakage Current	V_{GS} = ±20V, V_{DS} = 0V			±100	nA
On Characteristics						
$V_{GS(th)}$	Gate to Source Threshold Voltage	V_{GS} = V_{DS}, I_D = 1mA	1.0	2.1	3.0	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate to Source Threshold Voltage Temperature Coefficient	I_D = 10mA, referenced to 25°C		-5		mV/°C
$r_{DS(on)}$	Static Drain to Source On Resistance	V_{GS} = 10V, I_D = 18A		3.8	4.8	mΩ
		V_{GS} = 4.5V, I_D = 15A		5.3	7.0	
		V_{GS} = 10V, I_D = 18A, T_J = 125°C		5.3	7.8	
g_{FS}	Forward Transconductance	V_{DS} = 5V, I_D = 18A		78		S
Dynamic Characteristics						
C_{iss}	Input Capacitance	V_{DS} = 15V, V_{GS} = 0V, f = 1MHz		2005	2670	pF
C_{oss}	Output Capacitance			985	1310	pF
C_{rss}	Reverse Transfer Capacitance			135	205	pF
R_g	Gate Resistance	f = 1MHz		0.6	2.0	Ω
Switching Characteristics						
$t_{d(on)}$	Turn-On Delay Time	V_{DD} = 15V, I_D = 18A, V_{GS} = 10V, R_{GEN} = 6Ω		12	22	ns
t_r	Rise Time			4	10	ns
$t_{d(off)}$	Turn-Off Delay Time			26	42	ns
t_f	Fall Time			3	10	ns
Q_g	Total Gate Charge	V_{GS} = 0V to 10V; V_{DD} = 15V, I_D = 18A		29	41	nC
Q_g	Total Gate Charge	V_{GS} = 0V to 5V		15	21	nC
Q_{gs}	Gate to Source Charge			5.5		nC
Q_{gd}	Gate to Drain "Miller" Charge			3.7		nC
Drain-Source Diode Characteristics						
V_{SD}	Source to Drain Diode Forward Voltage	V_{GS} = 0V, I_S = 18A		0.8	1.2	V
		V_{GS} = 0V, I_S = 1.8A		0.4	0.7	
t_{rr}	Reverse Recovery Time	I_F = 18A, di/dt = 300A/µs		27	43	ns
Q_{rr}	Reverse Recovery Charge			31	50	nC

NOTES:
1. $R_{\theta JA}$ is determined with the device mounted on a 1in^2 pad 2 oz copper pad on a 1.5 x 1.5 in. board of FR-4 material. $R_{\theta JC}$ is guaranteed by design while $R_{\theta CA}$ is determined by the user's board design.

a) 50°C/W when mounted on a 1in^2 pad of 2 oz copper.



b) 125°C/W when mounted on a minimum pad.

2. Pulse Test: Pulse Width < 300µs, Duty cycle < 2.0%.
3. Starting T_J = 25°C, L = 3mH, I_{AS} = 12A, V_{DD} = 30V, V_{GS} = 10V.

Typical Characteristics $T_J = 25°C$ unless otherwise noted

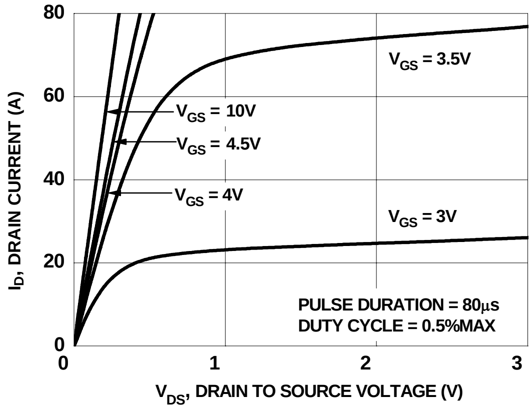


Figure 1. On-Region Characteristics

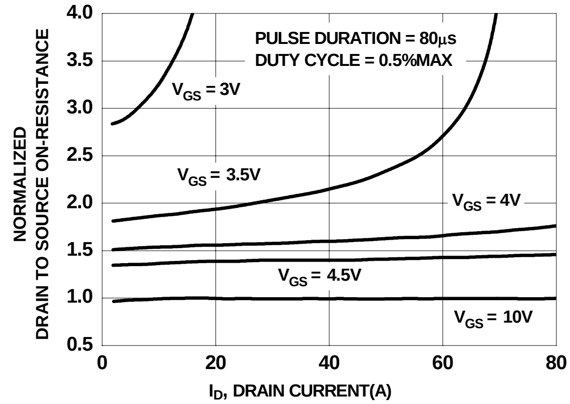


Figure 2. Normalized On-Resistance vs Drain Current and Gate Voltage

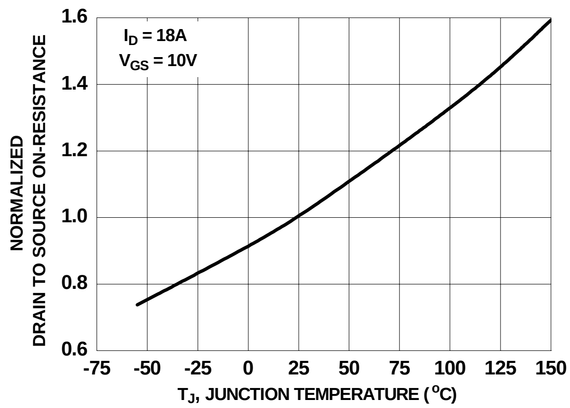


Figure 3. Normalized On-Resistance vs Junction Temperature

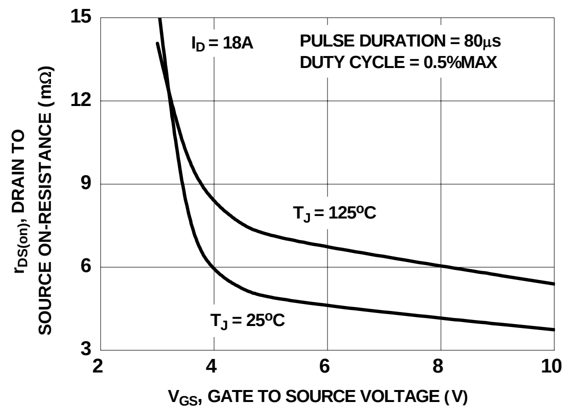


Figure 4. On-Resistance vs Gate to Source Voltage

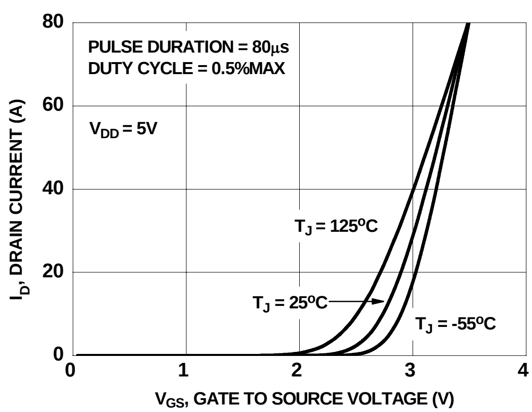


Figure 5. Transfer Characteristics

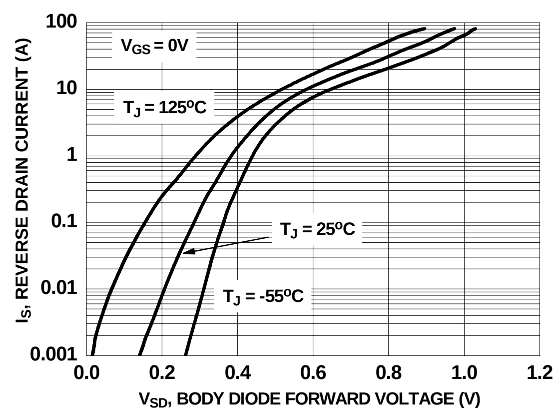


Figure 6. Source to Drain Diode Forward Voltage vs Source Current

Typical Characteristics $T_J = 25°C$ unless otherwise noted

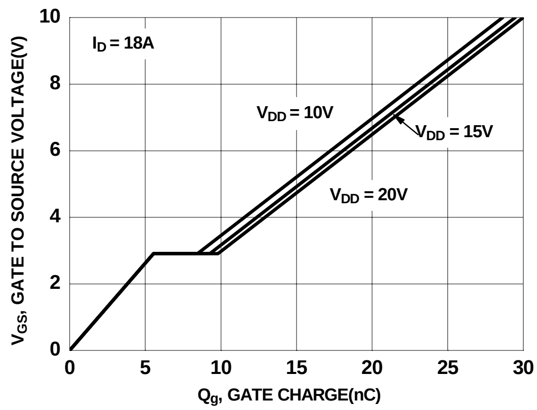


Figure 7. Gate Charge Characteristics

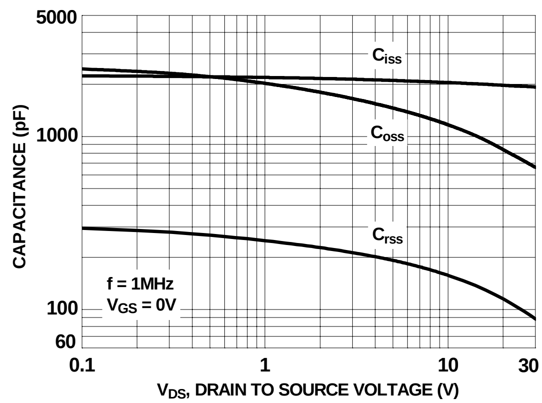


Figure 8. Capacitance vs Drain to Source Voltage

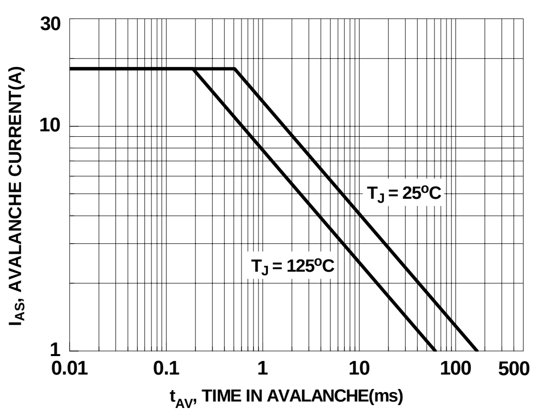


Figure 9. Unclamped Inductive Switching Capability

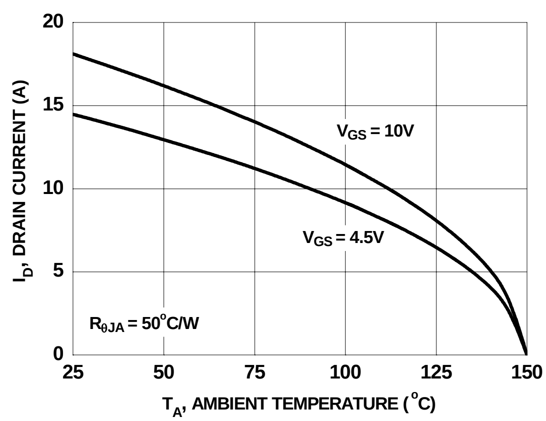


Figure 10. Maximum Continuous Drain Current vs Ambient Temperature

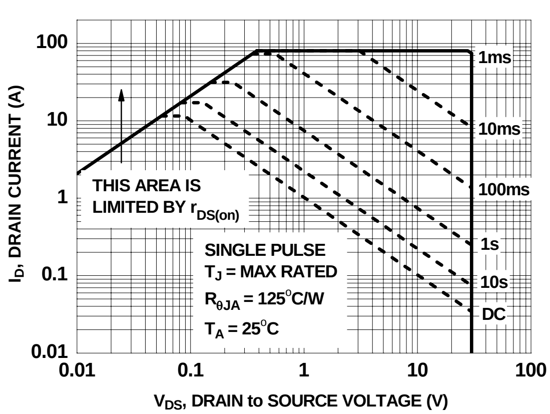


Figure 11. Forward Bias Safe Operating Area

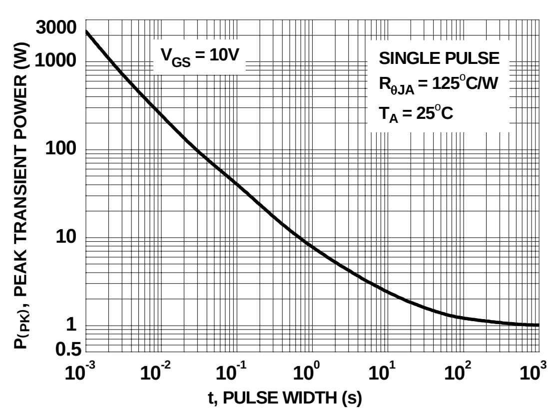


Figure 12. Single Pulse Maximum Power Dissipation

Typical Characteristics T_J = 25°C unless otherwise noted

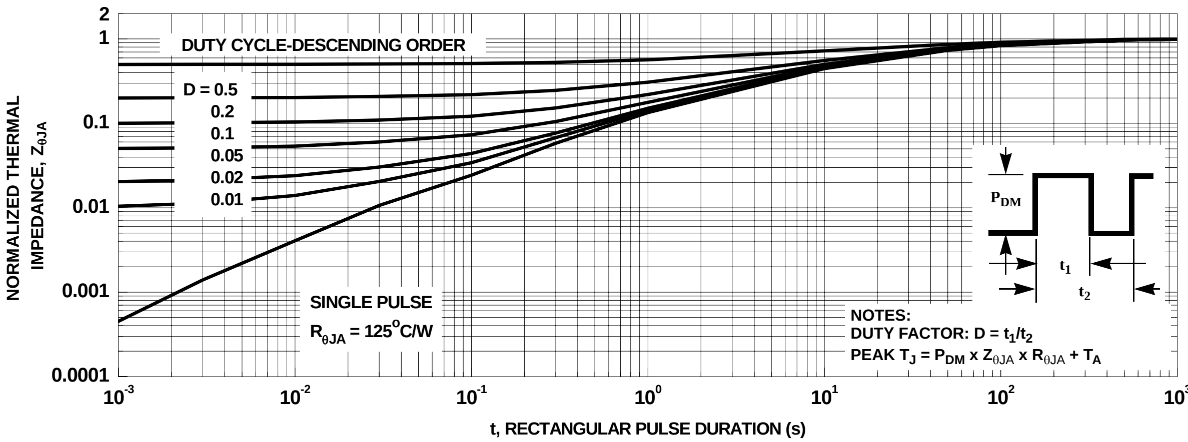


Figure 13. Transient Thermal Response Curve

Typical Characteristics T_J = 25°C unless otherwise noted

SyncFET Schottky Body Diode Characteristics

Fairchild's SyncFET process embeds a Schottky diode in parallel with PowerTrench MoSFET. This diode exhibits similar characteristics to a discrete external Schottky diode in parallel with a MOSFET. Figure 14 shows the reverse recovery characteristic of the FDS8672S.

Schottky barrier diodes exhibit significant leakage at high temperature and high reverse voltage. This will increase the power in the device.

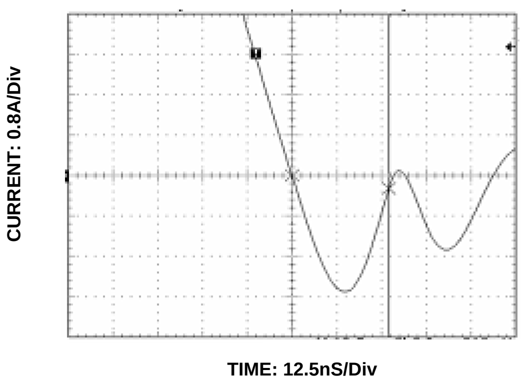


Figure 14. FDS8672S SyncFET Body Diode Reverse Recovery Characteristics

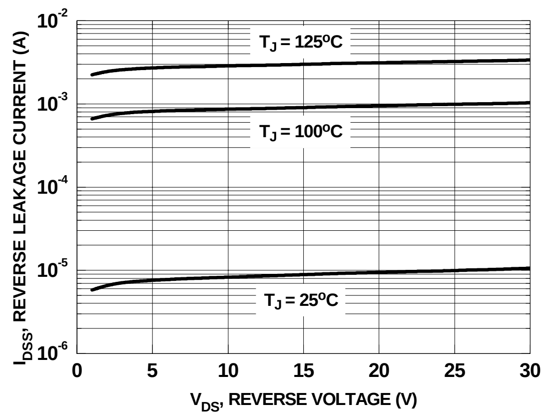


Figure 15. SyncFET Body Diode Reverse Leakage vs Drain to Source Voltage

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